

<b>Notice of References Cited</b>	Application/Control No. 10/659,595	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner David Vu	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,498,443	12-2002	Ueda et al.	315/368.11
*	B	US-4,910,441	03-1990	Wetta, Steven C.	315/371
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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